4F, NO. 16, Sec. 2 Chung Yang S Rd., Peitou, Taipei, Taiwan.

TEL: 886-2-2894-1202, 886-2-2895-2201 FAX: 886-2-2894-1206, 886-2-2895-6207 www.txccorp.com

SPECIFICATION FOR APPROVAL

CUSTOMER	:
PRODUCT TYPE	: SMD TSX 2.0*1.6
NOMINAL FREQ.	:19.2 MHz
TXC P/N	: OY19270002
REVISION	: S1
CUSTOMER P/N	:
PM / SALES	:
DATE	:2012/5/30
CUSTOMER SIGNAT	TURE & DATE
	:
(1) TXC requires one copy reacceptance of the attached	eturned with signature and title of authorized individual that signifies dispecifications.
(2) Orders received and according produced per these specifications.	repted by TXC after return of signed copy of specification will be rications.
(3) Any changes to these spec Product Specification Shee	cifications must be agreed upon by both parties and new revision of the et will be issued.
• • •	e order prior to consigning back the Approval page of "Specification will be regarded as the agreement on the contents of these
Attachment(s): V 1. Product Specification 2. Testing Report(Elect 3. Reliability Report	

FMT-DOC024 Issue date: 12.15 '08 VER.E

RoHS Compliant

4F, NO. 16, Sec. 2 Chung Yang S Rd., Peitou, Taipei, Taiwan.

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PRODUCT SPECIFICATION SHEET

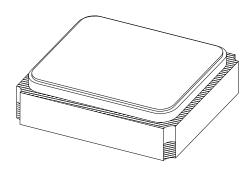
CUSTOMER :

PRODUCT TYPE : SMD TSX 2.0*1.6

NOMINAL FREQ. : 19.2 MHz

TXC P/N : OY19270002

REVISION : S1



RD	QA	MFG
Bruce Hsu Kenneth Kas		
2012/5/30		

NOTE:

- (1) Lead Free Products are "Directive 2002 / 95 / EC of The European Parliament of 27 January 2003 on the restriction of the use of certain hazardous substances (RoHS) in electrical and electronic equipment" Compliant (Attachment: SGS Test Report).
- (2) Revision "Sx" is for engineering samples only. PE/RD's approval required.
- (3) Revision "Ax" is production ready. PE, QA and MFG's approval required.

RoHS Compliant



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PRODUCT TYPE: SMD TSX 2.0*1.6 P/N: OY19270002 REVISION: S1

Rev	Revise page	Revise contents	<u>Date</u>	Ref.No.	<u>Reviser</u>
S1	N/A	Initial released	2012/5/30	N/A	Fenny Huang



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PRODUCT TYPE: SMD TSX 2.0*1.6 P/N: OY19270002 REVISION: S1

CRYSTAL ELECTRICAL SPECIFICATIONS

Standard Atmospheric Conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurement and tests are as follow:

Ambient temperature : $25\pm10^{\circ}$ C Relative humidity : $40\%\sim70\%$

If there is any doubt about the results, measurement shall be made within the following limits:

Ambient temperature : $25\pm3^{\circ}$ C Relative humidity : $40\%\sim70\%$

Measurement Equipment

Electrical characteristics measured by HP E5100A or equivalent

Crystal Cutting Type

The crystal is using AT CUT (thickness shear mode)

	Parameters Nominal Frequency Oscillation Mode Load Capacitance Frequency Tolerance Tolerance Over Temperature Frequency Drift After Reflow Operating Temperature Aging Drive Level Effective Resistance Rr Shunt Capacitance C0 Motional Capacitance C1 Insulation Resistance Storage Temperature Range Spurious Mode Series Resistance Q Factor First-order Curve Fitting Parameter Second-order Curve Fitting Parameter Third-order Curve Fitting Parameter Residual frequency stability slope 5°C small orbit hysteresis 1	Cumb al	Condition		Electric	al Spec.		Note
	Parameters	Symbol	Condition	Min.	Тур.	Max.	Units	Note
1	Nominal Frequency	FL			19.200000			
2	Oscillation Mode	-		F	undamenta	al		
3	Load Capacitance	CL			7		pF	1
4	Frequency Tolerance	-	+25°C ± 3°C			±10	ppm	
5	Tolerance Over Temperature	-	-30°C to +85°			±12	ppm	2
6	Frequency Drift After Reflow	-	two reflows			±2	ppm	
7	Operating Temperature	-		-30		+105	°C	
8	Aging	-				±0.7	ppm/Year	
9	Drive Level	DL		10		100	μW	
10	Effective Resistance Rr	Rr				80	Ω	
11	Shunt Capacitance C0	C0		0.3		1.3	pF	
12	Motional Capacitance C1	C1		1.8		3.1	fF	
13	Insulation Resistance	-	at DC 100 V	500			МΩ	
14	Storage Temperature Range	-	-	-40		+105	°C	
15	Spurious Mode Series Resistance	-	±1 MHz	1100			Ω	
16	Q Factor	Q		75000				3
17	First-order Curve Fitting Parameter	-		-0.4		-0.1	ppm/°C	4
18	Second-order Curve Fitting Parameter	-		-4.5	0	4.5	x10 ⁻⁴ ppm/°C ²	4
19	Third-order Curve Fitting Parameter	-		8.5	10	11.5	x10 ⁻⁵ ppm/°C ³	4
20	Residual frequency stability slope	-				±50	ppb/°C	5
21	5°C small orbit hysteresis 1	-				±50	ppb/°C	6
22	5°C small orbit hysteresis 2	-			100		ppb pk-pk	7



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PRODUCT TYPE: SMD TSX 2.0*1.6 P/N: OY19270002 REVISION: S1

	Davametera	Cumbal	Condition -	Electrical Spec.					
	Parameters	Symbol		Min.	Тур.	Max.	Units	Note	
23	DLD Freq (Max-Min)	-				3.0	ppm	8	
24	DLD Freq (Repeatability)	-				0.7	ppm	8	
25	DLD ESR (Max-Min)	-				20	%	8	
26	DLD ESR (Repeatability)	-				10	%	8	

Note 1	The load capacitance is	measured according	to IEC S	Standard #60444-7

- Note 2 Above 85°C tolerance over temperature bound by third-order coefficient range
- Note 3 Minimum Q value calculated from ESR and L is smaller than this specification
- Note 4 The curve fitting parameter is obtained from the Qualcomm crystal curve fitting algorithm, t0=32 °C (Refer to Curve Fitting Calculation Table: 80-V9690-26 Rev.C)

Noto 5	Condition 1A	A – Test condition	(continuous	temperature rate	change of	~1 0°C/min\·
NOLE		7 — 1 C SL COHUILIOH	1 COH III I I I I I I I I I I I I I I I I I	tellibelatule late	cilaliue oi	- 1.0 C/IIIII/.

- □ Measure FT points every 1°C, heating up from -30 to +85°C, subtract a fifth-order polynomial best fit and then calculate the slope of the residual.
- ☐ The residual slope should be within ±50 ppb/°C.

Note 6	Condition 1B - F	Hysteresis 1 te	st condition	(continuous ten	perature rate	change of	~1.0°C/min):
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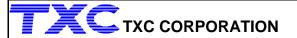
- □ Measure FT points every 0.5°C while cycling temperature over a 5°C small temperature orbit; an example 5°C small orbit temperature cycle is +30°C to +35°C to +30°C.
- During every individual heating/cooling cycle there should be 11 points; discard the first point of each heating and cooling cycle; this leaves 10 points for each heating and cooling cycle. Subtract the fifth-order polynomial best fit from 1A for each of the 10 points, and then calculate the slope of the residual for each of these heating and cooling 10 point curves.
- ☐ The residual slope should be within ±50 ppb/°C.

Note 7 Hysteresis 2 test condition (continuous temperature rate change of ~1.0°C/min):

- □ Measure FT points every 0.5°C while cycling temperature over a 5°C small temperature orbit; an example 5°C small orbit temperature cycle is +30°C to +35°C to +30°C.
- □ During every individual heating/cooling cycle there should be 11 points; discard the first and last point of each heating and cooling cycle, which results in 9 temperature points. Calculate the average measured peak-to-peak frequency difference for these 9 temperature points.
- □ The average difference is the magnitude of the small orbit hysteresis 2.

Note 8 0.01 uW to 100 uW to 0.01 uW, number of points: 15 points up and 15 points down = 29 total data points

Note 9 This crystal specification complies to Qualcomm Mini-Specification 80-V9690-26 Rev.C



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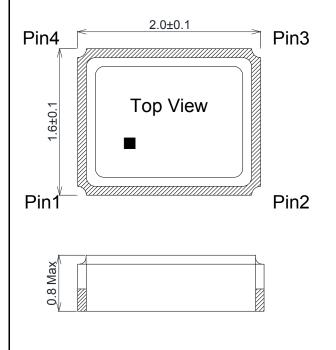
PRODUCT TYPE: SMD TSX 2.0*1.6 P/N: OY19270002 REVISION: S1

■ NTC THERMISTOR ELECTRICAL SPECIFICATIONS

	Parameters	Symbol	Condition		Electrical Spec.					
	Parameters	Symbol	Condition	Min.	Тур.	Max.	Units	Note		
1	Resistance (25 °C)				100k ± 1%					
2	B-Constant (25-50 °C)				K	1				
3	Operating Temperature			-30		+105	°C			

Note 1 The B constant is calculated using the zero-power resistance values measured at 25°C and 50°C

DIMENSIONS

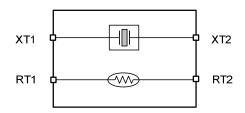


PIN FUNCTION

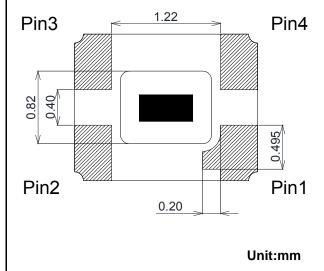
	Symbol	Function
Pin 1	XT1	XTAL Terminal 1
Pin 2	RT2	Thermistor Terminal 2
Pin 3	XT2	XTAL Terminal 2
Pin 4	RT1	Thermistor Terminal 1

Note: Pin 2 is connected to the metal lid and thermistor Pin 4 is connected to the thermistor only

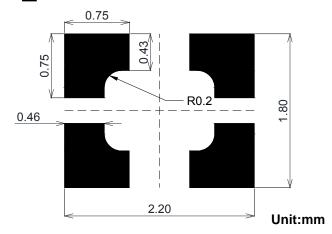
BLOCK DIAGRAM



Note: RT2 shall be connected to GND is recommended



SUGGESTED LAYOUT

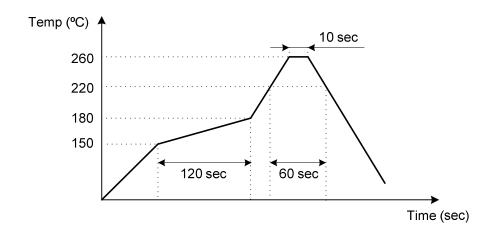




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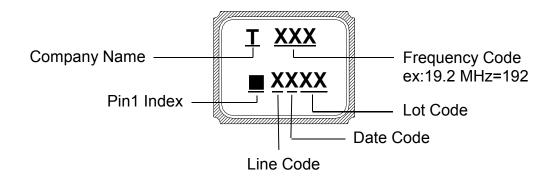
PRODUCT TYPE: SMD TSX 2.0*1.6 P/N: OY19270002 REVISION: S1

■ SUGGESTED REFLOW PROFILE



Note: Total Time: 200 sec. Max., Solder Melting Point: 220°C

MARKING



DATE CODE

YEAR	YEAR MONTH				FEB	MAR	APR	MAY	JUN	JUL	AUG	SEP	ОСТ	NOV	DEC
2005	2009	2013	2017	Α	В	С	D	Е	F	G	Н	J	K	L	М
2006	2010	2014	2018	N	Р	Q	R	S	Т	U	V	W	Х	Υ	Z
2007	2011	2015	2019	а	b	С	d	е	f	g	h	j	k	I	m
2008	2012	2016	2020	n	р	q	r	S	t	u	٧	W	Х	у	Z

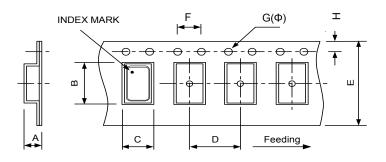
Note: This date code will be cycled every four years

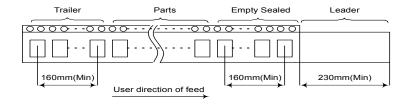


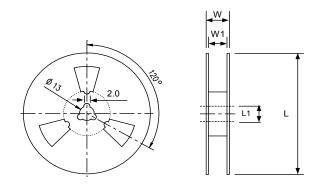
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PRODUCT TYPE: SMD TSX 2.0*1.6 P/N: OY19270002 REVISION: S1

■ PACKING: (EIA-481-2)







Unit: mm

													OTHE THIR	
DIMENSIONS	Α	В	C	D	Е	F	G	Н	L	L1	W	V V I	Standard Reel Quantity	
(mm)	0.65	2.30	1.90	4.00	8.00	4.00	1.55	1.75	178	13.0	11.5	8.0	is 3,000 pcs per reel	l

WEIGHT

0.0086 g / piece(TYP), 26 \pm 1.3 g /3 kpcs(regardless of tape weight)

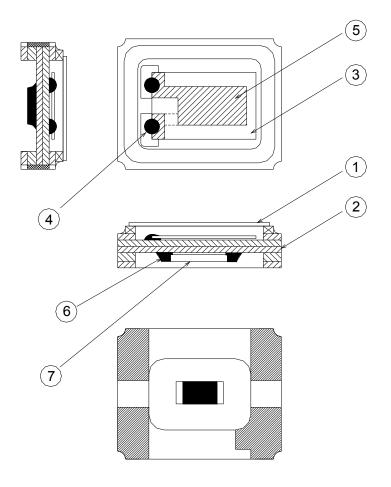


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PRODUCT TYPE: SMD TSX 2.0*1.6 P/N: OY19270002 REVISION: S1

■ STRUCTURE ILLUSTRATION

Crystal Enclosure Seal : Seam Welding



No.	COMPONENTS	MATERIALS	FINISH/SPECIFICATIONS
1	Lid	Metal (Fe+Co+Ni)	-
2	Base (Package)	Ceramic (Al ₂ O ₃) + Kovar (Fe+Co+Ni) + Ag/Cu	Alumina Ceramics
3	Crystal Blank	SiO ₂	-
4	Conductive Adhesive	Ag	Silicone Resin
5	Electrode	Noble Metal	-
6	Solder	Sn	-
7	Thermistor	Al ₂ O ₃ , Ag, Ni	-



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PRODUCT TYPE: SMD TSX 2.0*1.6 P/N: OY19270002 REVISION: S1

■ RELIABILITY SPECIFICATIONS

1. Mechanical Endurance

No.	Test Item	Test Methods		Reference
1.1	Drop Test	150 cm height, 3 times on concrete floor.		JIS C6701
1.2	Mechanical Shock	Device are shocked to half sine wave (1000 G) three mutually		MIL-STD-202
		perpendicular axes each 3 times. 0.5 msec. duration time		
1.3	Vibration	Frequency range	10 ~ 2000 Hz	MIL-STD-883
		Amplitude	1.52 mm/20 G	
		Sweep time	20 minutes	
		Perpendicular axes each test time	4 Hrs	
			(Total test time 12 Hrs)	
1.4	Gross Leak	Standard sample for automatic gross leak detector		MIL-STD-883
		Test pressure: 2 kg / cm ²		
1.5	Fine Leak	Helium bombing 4.5 kg/ cm ² for 2 Hrs		
1.6	Solderability	Temperature	245°C ± 5°C	
		Immersing depth	0.5 mm minimum	MIL-STD-883
		Immersion time	5 ± 1 seconds	
		Flux	Rosin resin methyl alcohol	
			solvent (1:4)	

2. Environmental Endurance

No.	Test Item	Test Methods	Reference
2.1	Resistance To Soldering Heat	Pre-heat temperature 125° C Pre-heat time $60 \sim 120 \text{ sec.}$ Test temperature $260 \pm 5^{\circ}$ C Test time $10 \pm 1 \text{ sec.}$	MIL-STD-202
2.2	High Temp. Storage	+ 125 °C ± 3 °C for 500 ± 12 Hrs	MIL-STD-883
2.3	Low Temp. Storage	- 40°C ± 3°C for 500 ± 12 Hrs	
2.4	Thermal Shock	Total 100 cycles of the following temperature cycle 125 ± 3°C 25°C -55 ± 3°C 30 min. 10 min. max.	MIL-STD-883
2.5	High Temp&Humidity	85°C ± 3°C, RH 85% , 500 Hrs	JIS C5023